

Search Notes

Application No.

10/632,641

Examiner

Edward Wojciechowicz

Applicant(s)

CHANG ET AL.

Art Unit

2815

SEARCHED

Class	Subclass	Date	Examiner
257	347, 348	9-30-04	EW

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR